

Introduction

This errata sheet describes functional and electrical problems of the SPC584Nx, SPC58ENx, SPC58NNx devices.

The reference documentation is reported in [Chapter 2: Reference document](#).

Device identification for cut 1.1:

- JTAG_ID = 0x1011_2041
- MIDR1 register:
 - MAJOR_MASK[3:0]: 4'b0000
 - MINOR_MASK[3:0]: 4'b0001

Errata and BAF related errata are contained in Microsoft Excel[®] workbook files attached to this document.

Locate the paper clip symbol on the left side of the PDF window, and click it. Double-click on the Excel file to open it.

1 BAF Image version

The BAF version is a 32-bit field in the image header starting at address 0x0040_4000. The 32 bit-bit field is explained in the following table.

Table 1. BAF Image version registers

Field	Description
0:7	Major Number: This field contains the major version number for the BAF image
8:15	Minor Number: This field contains the minor version number for the BAF image
16:31	Reserved

2 Reference document

Table 2. Reference documents

Doc name	ID	Title	Revision
RM0421	DM00239196	SPC58xNx 32-bit Power Architecture® microcontroller for automotive ASILD applications	3
DS11734	DM00307505	32-bit Power Architecture® microcontroller for automotive ASIL-D applications	5

Revision history

Table 3. Document revision history

Date	Revision	Changes
30-Jun-2017	1	Initial release
13-Dec-2017	2	<p>1) GTM erratum removed (not applicable to SPC58xNx)</p> <ul style="list-style-type: none"> – DAN-0041994 GTM: Loss of data for PMT transfer to DPLL via ARU <p>Removed errata</p> <ul style="list-style-type: none"> – DAN-0043282 FUSE: VDD_HV supply of FUSE is not connected <p>ID change for an erratum: legacy ID had been picked up in previous generation the current one would be the correct one</p> <ul style="list-style-type: none"> – DAN-0042364 AMU: Incorrect operation with spurious MEMU/FCCU errors when AMU is working with APC enabled. <p>=></p> <ul style="list-style-type: none"> – DAN-0042750 AMU: Incorrect operation with spurious MEMU or FCCU errors when AMU is working with APC enabled. <p>8 new normal errata (5 GTM)</p> <ul style="list-style-type: none"> – DAN-0043442 GTM: TIM Serial shift mode (TSSM) no capture on bit number event if external capture is enabled – DAN-0043443 GTM: TOM/ATOM CCU0 interrupt at the wrong time in case of RST_CCU0=1 – DAN-0044106 GTM: Accessing MCS RAM while disabling last MCS channel fails – DAN-0044107 GTM: Access to the ADC interface address range by MCS while a CPU access to an address in the same cluster is pending will stall the MCS bus master interface – DAN-0044108 GTM: If the buffer of a MCS bus master interface is full and new accesses are scheduled by other MCS channels, the MCS bus master interface will block forever – DAN-0044109 Q100-JEDEC78D: Device non-compliant with Pin Latch-up I-tests on some pads – DAN-0044555 LINFlexD: in UART mode, receiver can miss counting incoming frames if framing errors are present – DAN-0045056 Decimation filter: No transfer error generated for accesses within the unused range of the decimation filter peripheral memory map <p>NOTE: DAN-0044109 is the PS2992 erratum (Pad latchup), figuring with a distinct DAN ID</p>
02-Feb-2018	3	<p>Removed errata (not applicable to Bernina):</p> <ul style="list-style-type: none"> – PS864 MEMU ECC bits not included in MEMU error log (ERR005611) <p>BAF 01.01 Errata</p>

Table 3. Document revision history (continued)

Date	Revision	Changes
06-Jul-2020	4	<p>Removed errata:</p> <ul style="list-style-type: none"> - ERR006836 DCF: DCF record for initial IVPR cannot be used <p>New Errata:</p> <ul style="list-style-type: none"> - DAN-0041121 SARADC: Some MCR register bits should not be asserted high together. - DAN-0041154 [DOC] SARADC: need to check MSR register before raising new command - DAN-0041182 SAR ADC: Normal conversion chain does not resume correctly if interrupted. - DAN-0043474 SARADC: The delay programmed in ECSDR.DSD occurs before setting the external multiplexer pins - DAN-0044114 JTAGM: JTAGM_SR[15] may not report the debugger connection - DAN-0046042 GTMINT: GTM (Generic Timer Module) DTM Module Auxiliary Inputs may not function correctly - ERR008310 XBIC: Crossbar Integrity Checker may miss recording information from an initial fault event in the case of back-to-back faults - ERR008547 e200z425: Additional cycles required for Load/Store accesses to guarded/precise space <p>Reworded errata:</p> <ul style="list-style-type: none"> - DAN-0043138 STCU2: False FCCU alarms and MEMU entries after On line self-test execution of LBIST partition 0, 3, 4 or 5. - DAN-0043599 MEMU: Fake entries after offline LBIST execution on Partition0 - DAN-0043762 SDADC: Degraded common mode rejection ratio (Vcmrr) and absolute value of the ADC gain error (dGAIN) values. - ERR007701 STCU2: Short Functional Reset reaction and Long Functional Reset reaction of the FCCU does not take effect upon PLL1 Loss-Of-Lock while MBIST ONLINE is running - ERR007869 FCCU: FOSU monitoring of a fault is blocked for second or later occurrence of the same fault - ERR008145 MEMU: address registers in the uncorrectable error reporting tables can be written when the corresponding valid bit is not asserted <p>BAF 01.01 Rev 2.</p> <p>Added errata:</p> <ul style="list-style-type: none"> - DAN-0044825 MC_CGM: CGM_ACx_SC registers not reset after a destructive reset event - DAN-0046237 BAF: TDM diary size in use is 2K instead of 4K

Table 3. Document revision history (continued)

Date	Revision	Changes
05-Oct-2018	5.0	<p>New Errata:</p> <ul style="list-style-type: none"> - DAN-0043444 GTM: TIM captured value in TIM[i]_CH[x]_GPR1 incorrect - DAN-0043446 GTM: AEI configuration interface using standard protocol in synchronous mode with write-buffer enabled may behave incorrectly (a write transaction can be executed twice) - DAN-0043447 GTM: AEI configuration interface using pipelined protocol writing to GTM_BRIDGE_MODE not fully functional - DAN-0043628 MC_CGM: CGM_ACx_SC registers not reset after a destructive reset event - DAN-0046687 GTM: Back-to-back TIM data transfers at full ARU clock rate cannot be transferred correctly with ARU dynamic routing mode - DAN-0046689 GTM: Aborting an AEI access to the GTM when bridge buffer is full results in an unexpected behavior - DAN-0046692 GTM: unexpected (A)TOM_CCU1TCx_IRQ interrupts in (A)TOM configured in up/down counter mode - DAN-0046703 GTM: GTM_HALT_ACTIVE signal incorrect - DAN-0047497 STCU2: Device can get stuck after execution of online MBIST - DAN-0047602 [DOC] SDADC: Full scale values as mentioned in Reference Manual chapter "Gain Calibration support" may vary with different OSR configurations. - DAN-0047687 e200z425: Specific instructions executed immediately after reset can cause RCCU alarms of the core to be asserted. - DAN-0047977 MCAN: Unexpected High Priority Message (HPM) interrupt. - DAN-0047979 MCAN: Message transmitted with wrong arbitration and control fields. - DAN-0047983 Interrupt flag IR.ARA not set when accessing reserved addresses 0x144 to 0x1FF. - DAN-0047984 MTTTCAN: Unexpected High Priority Message (HPM) interrupt. - DAN-0047985 MTTTCAN: Message transmitted with wrong arbitration and control fields. - DAN-0048196 [DOC] PMC_DIG: wrong description of timing values for testing of voltage monitor BIST - DAN-0048198 SDADC: Degraded VDD_HV_ADV power supply current (each ADC IADV_D) and BIAS consumption (IBIAS) - DAN-0048204 SIUL2: Incorrect flash size value reported by MIDR2 register - DAN-0048205 STCU2: Spurious faults on FCCU channel 10 and/or 12 may occur after Online self-test <p>Reworded errata:</p> <ul style="list-style-type: none"> - PS2949 - PS2582 - PS2817 - PS3021 - ERR007869

Table 3. Document revision history (continued)

Date	Revision	Changes
7-Jun-2019	6.0	<p>Modified Errata:</p> <ul style="list-style-type: none"> - PS2231 - PS3021 <p>New ERRATA:</p> <ul style="list-style-type: none"> - DAN-0048189 - DAN-0048576 - DAN-0048678 - DAN-0048968 - DAN-0049480 - DAN-0049907 - ERR007873 <p>Removed ERRATA:</p> <ul style="list-style-type: none"> - ERR007791 - DAN-0041154 - DAN-0048196 - DAN-0047602
10-Dec-2019	7.0	<p>Reworded Errata:</p> <ul style="list-style-type: none"> - DAN-0041120 (PS2857) <p>New Errata:</p> <ul style="list-style-type: none"> - DAN-0048664 - DAN-0049972 (Security) - DAN-0050273 - DAN-0050583 - DAN-0050632 - ERR010436
06-Jul-2020	8.0	<p>New Errata:</p> <ul style="list-style-type: none"> - DAN-0051367 - DAN-0051392 - ERR009658 - ERR010542 <p>Reworded Errata:</p> <ul style="list-style-type: none"> - DAN-0042615

IMPORTANT NOTICE – PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries (“ST”) reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST’s terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers’ products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. For additional information about ST trademarks, please refer to www.st.com/trademarks. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2020 STMicroelectronics – All rights reserved